

SSC8L660GN6

Dual N-Channel Enhancement Mode MOSFET

> Features

V _{DS}	V _{GS}	R _{DS(ON)} Typ.	l _D
60V	±20V	8.5 mΩ@10V	56A
000	<u> </u>	12.5 mΩ@4.5V	30A

Description

This device is N-Channel enhancement MOSFET.

Uses SGT technology and design to provide excellent

RDSON with low gate charge. This device is suitable
for use in DC-DC conversion, power switch and
charging circuit.

100% UIS + ΔVDS + Rg Tested!

Applications

- Motor Drive Control
- DCDC Conversion
- Power Supplies
- Synchronous Rectification

> Ordering Information

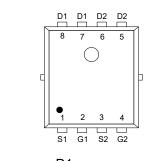
Device	Package	Shipping
SSC8L660GN6	PDFN5X6-8L	5000/Reel

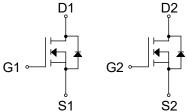
> Pin Configuration





PDFN5X6-8L





Pin Configuration (Top View)



Marking

(XXYY: Internal Traceability Code)



➤ Absolute Maximum Ratings (T_A=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit		
V _{DSS}	Drain-to-Source Voltage		60	V	
V _{GSS}	Gate-to-Source Volta	Gate-to-Source Voltage		V	
	Outine Dail Ownedd	T _C =25℃	56	^	
l _D	Continuous Drain Current d	T _C =100℃	36	A	
	Outlines Paris Commits	T _A =25℃	12	Δ.	
ldsм	Continuous Drain Current ^a	T _A =70°C	10	A	
I _{DM}	Pulsed Drain Curren	t ^b	225	Α	
Б	5 5	Tc=25°C	57	10/	
P _D	Power Dissipation ^c	T _C =25℃ T _C =100℃	23	W	
<u> </u>	Power Dissipation ^a	T _A =25℃	2.7	34/	
P _{DSM}		T _A =70°C	1.7	W	
las	Avalanche Current ^b L=0.5mH Single Pulse		18	Α	
Eas	Avalanche Energy ^b L=0.5mH Single Pulse		81	mJ	
TJ	Operation junction temperature		-55~150	°C	
Тѕтс	Storage temperature range		-55~150	$^{\circ}\!\mathbb{C}$	

➤ Thermal Resistance Ratings (T_A=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit
ReJA	Junction-to-Ambient Thermal Resistance ^a	47	°C/W
R _{θJC}	Junction-to-Case Thermal Resistance	2.2	C/VV

Note:

- a. The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2oz.copper, in a still air environment with T_A=25°C. The value in any given application depends on the user is specific board design. The power dissipation is based on the t≤10s thermal resistance rating.
- b. Repetitive rating, pulse width limited by junction temperature.
- c. The power dissipation P_D is based on $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.
- d. The maximum current rating is package limited.

SSC-V1.1 www.sscsemi.com Analog Future



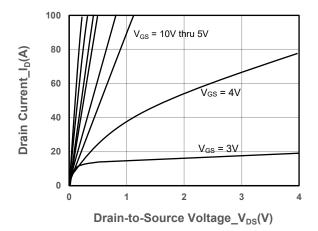
SSC8L660GN6

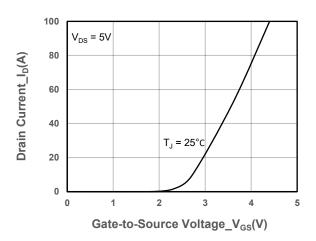
➤ Electrical Characteristics (T_A=25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250µA	60			V
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250$ uA	1.0	1.8	2.5	V
Drain-Source On-Resistance	R _{DS(on)}	V _{GS} = 10V, I _D = 20A		8.5	12.5	mΩ
Drain-Source On-Resistance	R _{DS(on)}	V _{GS} = 4.5V, I _D = 10A		12.5	18	mΩ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 60V, V _{GS} = 0V			1	μA
Gate-Source Leak Current	Igss	V _{GS} = ±20V, V _{DS} = 0V			±100	nA
Transconductance	G _{FS}	V _{DS} = 5V, I _D = 10A		20		S
Forward Voltage	V _{SD}	V _{GS} = 0V, I _S = 10A		0.8	1.3	V
Gate Resistance	R _G	V _{DS} = 0V, f = 1MHz		1.4		Ω
Input Capacitance	Ciss	V - 20V V - 0V		980		
Output Capacitance	Coss	$V_{DS} = 30V, V_{GS} = 0V,$		435		pF
Reverse Transfer Capacitance	Crss	f = 1MHz		36		
Total Gate Charge	Q _G	10// 20//		17		
Gate to Source Charge	Q _G s	V _{GS} = 10V, V _{DS} = 30V,		2.8		nC
Gate to Drain Charge	Q _{GD}	I _D = 20A		3.7		
Turn-on Delay Time	T _{D(ON)}			4.9		
Rise Time	Tr	V _{GS} = 10V, V _{DS} = 30V,		3.9]
Turn-off Delay Time	$T_{D(OFF)}$	$I_D = 20A, R_G = 3\Omega$		18		ns
Fall Time	T _f			7.5		
Diode Recovery Time	Trr	I _F =20A, di/dt=500A/us		23		ns
Diode Recovery Charge	Qrr	I _F =20A, di/dt=500A/us		53		nC

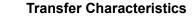


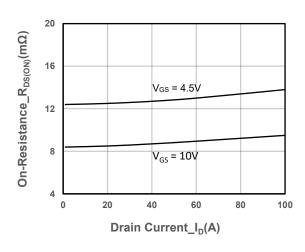
➤ Typical Performance Characteristics (T_A=25°C unless otherwise noted)

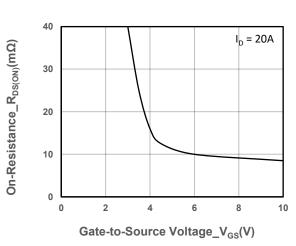




Output Characteristics

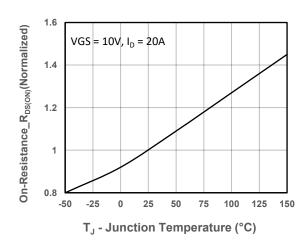


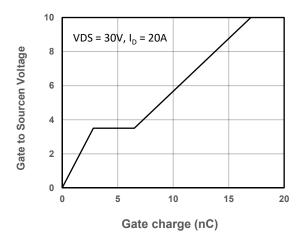




On-Resistance vs. Drain Current and Gate Voltag

On-Resistance vs. Gate-to-Source Voltage



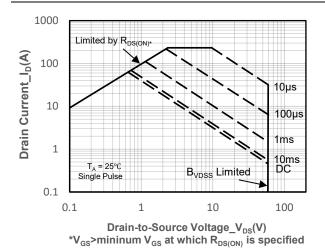


On-Resistance vs. Junction Temperature

Gate-Source Voltage vs. Gate charge

4 / 7

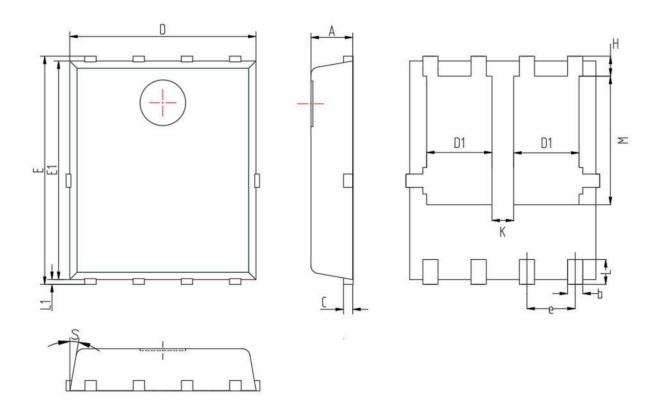




Safe Operating Area vs. Junction-to-Ambient



Package Information



Cumple of	MILL IMETER			
Symbol	Min	Nom	Max	
А	0.9	1.10	1.20	
b	0.25	0.30	0.5	
С	0.20	0.25	0.35	
D	4.80	5.00	5.20	
D1	1.50	1.70	1.80	
E	5.90	6.00	6.30	
E1	5.60	5.75	5.90	
е	1.27BSC			
Н	0.48	0.58	0.80	
K	0.50	0.60	0.70	
L	0.50	0.60	0.84	
L1	0.10	0.15	0.30	
M	3.30	3.48	3.67	
S	12° BSC			



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